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Nuclear Science, IEEE Transactions on , Volume: 41 Issue: 4 , Aug 1994

Page(s): 1104 -1108

[\[Abstract\]](#) [\[PDF Full-Text \(352 KB\)\]](#) **IEEE JNL****3 A vertically integrated test methodology based on JTAG IEEE 1149.1 Standard Interface***Ruparel, K.N.; Chin, C.; Fitzgerald, J.;*

ASIC Conference and Exhibit, 1991. Proceedings., Fourth Annual IEEE International , 23-27 Sept. 1991

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[\[Abstract\]](#) [\[PDF Full-Text \(376 KB\)\]](#) **IEEE CNF****4 Functional test and diagnosis: a proposed JTAG sample mode scan tester***Lefebvre, M.E.;*

Test Conference, 1990. Proceedings., International , 10-14 Sept. 1990

Page(s): 294 -303

[\[Abstract\]](#) [\[PDF Full-Text \(592 KB\)\]](#) **IEEE CNF****5 Tradeoff decisions made for a P1149.1 controller design [ATE]***Vining, S.;*

Test Conference, 1989. Proceedings. 'Meeting the Tests of Time', International , 29-31 Aug. 1989

Page(s): 47 -54

[\[Abstract\]](#) [\[PDF Full-Text \(444 KB\)\]](#) **IEEE CNF**

6 BIST and boundary-scan for board level test: test program pseudocode*Tulloss, R.E.; Yau, C.W.;*

European Test Conference, 1989., Proceedings of the 1st , 12-14 April 1989

Page(s): 106 -111

[\[Abstract\]](#) [\[PDF Full-Text \(500 KB\)\]](#) **IEEE CNF****7 IEEE-1149.1 use in design for verification and testability at Texas Instruments***Cron, A.D.;*

ASIC Seminar and Exhibit, 1989. Proceedings., Second Annual IEEE , 25-28 Sept. 1989

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Page(s): 289 -292

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Test Conference, 1997. Proceedings., International , 1-6 Nov. 1997

Page(s): 636 -639

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Application and Development of the Boundary-Scan Standard, IEE Colloquium on , 19 Dec 1990

Page(s): 5/1 -5/3

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Page(s): 218 -219, 448

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Compcon '96. 'Technologies for the Information Superhighway' Digest of Papers , 25-28 Feb. 1996

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Page(s): 377

[\[Abstract\]](#) [\[PDF Full-Text \(384 KB\)\]](#) **IEEE CNF****7 Rapid migration to VLSI***Lowinski, W.B.; Kirwan, R.; Perry, A.; Yu, T.;*

Aerospace and Electronics Conference, 1992. NAECON 1992., Proceedings of the IEEE 1992 National , 18-22 May 1992

Page(s): 97 -100 vol.1

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Aerospace and Electronic Systems Magazine, IEEE , Volume: 7 Issue: 9 , Sept. 1992

Page(s): 21 -23

[\[Abstract\]](#) [\[PDF Full-Text \(216 KB\)\]](#) **IEEE JNL****9 Sendfax a single chip fax and data modem***Lindsay, G.;*

Circuits and Devices for Data Communications, IEE Colloquium on , 28 Nov 1989

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[\[Abstract\]](#) [\[PDF Full-Text \(200 KB\)\]](#) **IEEE CNF****10 A single-chip 300 baud FSK modem***Takla, A.K.; Haque, V.A.;*

Solid-State Circuits, IEEE Journal of , Volume: 19 Issue: 6 , Dec 1984

Page(s): 846 -854

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Solid-State Circuits, IEEE Journal of , Volume: 15 Issue: 1 , Feb 1980

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OCEANS , Volume: 9 , Sep 1977

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 Document Analysis and Recognition, 1999. ICDAR '99. Proceedings of the Fifth International Conference
 on , 20-22 Sept. 1999
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ISO/IEC 8802-5, ANSI/IEEE Std 802.5, 3rd edn. 1998 , 26 May 1998

[Abstract] [PDF Full-Text (12500 KB)] IEEE STD

4 Feature-based Thai unknown word boundary identification using Winnow

Charoenpornasawat, P.; Kijirikul, B.; Meknavin, S.;
Circuits and Systems, 1998. IEEE APCCAS 1998. The 1998 IEEE Asia-Pacific Conference on , 24-27 Nov.
1998
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5 Fault-tolerant broadcasts in CAN

Rufino, J.; Verissimo, P.; Arroz, G.; Almeida, C.; Rodrigues, L.;
Fault-Tolerant Computing, 1998. Digest of Papers. Twenty-Eighth Annual International Symposium on , 23-
25 June 1998
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6 A system for segmentation and recognition of totally unconstrained handwritten numeral strings

Shi, Z.; Srihari, S.N.; Shiu, Y.-C.; Ramanaprasad, V.;

Document Analysis and Recognition, 1997., Proceedings of the Fourth International Conference on , Volume: 2 , 18-20 Aug. 1997

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7 Information technology - telecommunications and information exchange between systems - local and metropolitan area networks - specific requirements. Part 5: token ring access method and physical layer specifications

ISO/IEC Std 8802-5, 1995, ANSI/IEEE Std 802.5-1995 , 29 Dec. 1995

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IEEE Std 716-1995 , 12 Oct. 1995

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Azokly, A.; Ingold, R.;

Document Analysis and Recognition, 1995., Proceedings of the Third International Conference on , Volume: 2 , 14-16 Aug. 1995

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10 Fieldbus interface control IC

Yoshida, Y.; Mizoe, K.; Matsuda, A.; Kuroiwa, S.;

Instrumentation and Measurement Technology Conference, 1994. IMTC/94. Conference Proceedings. 10th Anniversary. Advanced Technologies in I & M., 1994 IEEE , 10-12 May 1994

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11 Blush and Zebrackets: large- and small-scale typographical representation of nested associativity

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Visual Languages, 1992. Proceedings., 1992 IEEE Workshop on , 15-18 Sept. 1992

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12 Text compression using several Huffman trees

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Data Compression Conference, 1991. DCC '91. , 8-11 April 1991

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Ramakrishnan, K.K.; Yang, H.;
Local Computer Networks, 1990. Proceedings., 15th Conference on , 30 Sept.-3 Oct. 1990
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14 Description of and experimental results for a high data rate underwater acoustic telemetry link

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Autonomous Underwater Vehicle Technology, 1990. AUV '90., Proceedings of the (1990) Symposium on , 5-6 June 1990
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15 Error characteristics of fiber distributed data interface (FDDI)

Jain, R.;
Communications, IEEE Transactions on , Volume: 38 Issue: 8 , Aug. 1990
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16 Access control module for local integrated optical network

Pallios, V.; Antonakopoulos, T.; Makios, V.;
Electronics Letters , Volume: 25 Issue: 3 , 2 Feb. 1989
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17 A high speed access mechanism for a multiservice LAN at 144 Mbps

Pallios, V.; Antonakopoulos, T.; Makios, V.;
Electrotechnics, 1988. Conference Proceedings on Area Communication, EUROCON 88., 8th European Conference on , 13-17 June 1988
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18 On the Impact of HDLC Zero Insertion and Deletion on Link Utilization and Reliability

Joong Ma;
Communications, IEEE Transactions on [legacy, pre - 1988] , Volume: 30 Issue: 2 , Feb 1982
Page(s): 375 -381

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19 The parsing program for automatic text-to-speech synthesis developed at the electrotechnical laboratory in 1968

Umeda, N.; Teranishi, R.;
Acoustics, Speech, and Signal Processing [see also IEEE Transactions on Signal Processing], IEEE Transactions on , Volume: 23 Issue: 2 , Apr 1975
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ACM SIGARCH Computer Architecture News , Proceedings of the 21ST annual international symposium on Computer architecture
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 Volume 22 Issue 2
 The *Multipath Enhanced Transit Router Organization (METRO)* is a flexible routing architecture for high-performance, tightly-coupled, multiprocessors and routing hubs. A *METRO* router is a dilated cross-bar routing component supporting half-duplex bidirectional, pipelined, circuit-switched connections. Each *METRO* router is self-routing and supports dynamic message traffic. The routers works in conjunction with source-responsible network interfaces to achieve reliable en ...
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 The Starfire interconnect extends the envelope of Unix symmetric multiprocessor (SMP) systems in several dimensions. **Interconnect:** an active centerplane with four address routers and a 16x16 data crossbar provides 64 UltraSPARC processors with uniform memory access at a bandwidth of 10,667 MBps. **Flexibility:** Starfire can be dynamically reconfigured into multiple hardware-protected operating system domains. **Robustness:** Failing boards can be hot swapped without interrupting sy ...
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Proceedings of the conference on Design, automation and test in Europe February 1998
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 Mobile and personal communication systems form key market areas for the electronics industry of the nineties. Stringent requirements in terms of flexibility, performance and power dissipation, are driving the development of integrated circuits into the direction of heterogeneous single-chip solutions. New IC architectures are emerging which contain the core of a powerful programmable processor, complemented with dedicated hardware, memory and interface structures. In this tutorial we will d ...

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Erwin Trischler
21st Proceedings of the Design Automation Conference on Design automation June 1984
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Linux Journal January 1999

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H. S. Fung , S. Hirschhorn , R. Kulkarni
Proceedings of the 22nd ACM/IEEE conference on Design automation June 1985
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We present two algorithms, called list-based scheme and tree-based scheme, to compute bridging fault (BF) coverage of IDDQ tests. These algorithms use the novel ideal of "indistinguishable pairs," which makes it more efficient and versatile than known fault simulation algorithms. Unlike known algorithms, the two algorithms can be used for combinational as well as sequential circuits and for arbitrary sets of BFs. Experiments sho ...

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